

# THERMINIC<sup>2013</sup>

|| 19th INTERNATIONAL WORKSHOP  
Thermal Investigations of ICs and Systems ||

SEPTEMBER 25 – 27, 2013 @ FRAUNHOFER FORUM BERLIN



**PROGRAMME**

# THERMINIC<sup>2013</sup>

## Programme

Organized by:



Sponsored by:



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## PREFACE

## WELCOME TO THERMINIC 2013!

Organised yearly since 1995, the THERMINIC Workshop series has become the premier venue for academics and industry to present and discuss the latest developments in essential and emerging thermal questions and best practices in the field of microelectronics. Just like its highly successful predecessor events in Grenoble (1995), Budapest (1996), Cannes (1997 and 1998), Rome (1999), Budapest (2000), Paris (2001), Madrid (2002), Aix-en-Provence (2003), Sophia Antipolis (2004), Belgirate (2005), Nice (2006), Budapest (2007), Rome (2008), Leuven (2009), Barcelona (2010), Paris (2011), and Budapest (2012), Therminic 2013 will again feature a powerful technical program, with 54 oral and 23 poster presentations in 14 sessions. Well over 100 conference delegates from 20 countries are joining us this year.

This program has been designed as a navigator for your conference participation. It includes not just all the sessions, presentations and evening events, but also the venue floor plan, timetable and crucial information to help make the most of your stay in Berlin. Note that the days have been color-coded for easier handling.

Each day kicks off with a keynote by a global player from industry. Thomas Brunschwiler (IBM Research), Berthold Hellenthal (AUDI AG) and Theo Treurniet (Philips Lighting) will share their insights on thermal challenges for microprocessor and high performance computing, for automotive electronics, and for solid state lighting, respectively.

Wednesday morning through to Friday afternoon are dedicated to technological sessions, which have been organized into 12 main thermal topics. The Friday, for the first time, offers a parallel session on the Smartpower and Nanotherm projects.

Don't forget the conference's evening program. The cocktail reception on Wednesday evening in the Fraunhofer Forum's exhibition area will be a first opportunity to mingle with old and new contacts and the concurrent poster session should be a great chance to discover new potential and exciting young projects. Then rev up your conference spirit at THERMINIC's Thursday night guided boat tour on the river Spree.

Apart from the opportunity to participate in what we believe will be some truly inspiring research presentations, on a personal level we also hope THERMINIC 2013 will be a chance for us to meet new colleagues and reconnect with trusted partners. Please bring your ideas, comments and suggestions – anything at all that you feel will help us provide a better service to you.

We look forward to spending a perfect late summer conference with you at THERMINIC 2013 in Berlin.



**Peter E. Raad**  
General Chair



**Márta Rencz**  
Vice General



**Bernhard Wunderle**  
Programme Chair



**András Poppe**  
Programme Vice Chair

**General Chair:** Peter Raad, Southern Methodist University, Dallas, USA  
**Vice General Chair:** Marta Rencz, Budapest University of Technology & Economics, Hungary  
**Programme Chair:** Bernhard Wunderle, Chemnitz University of Technology, Germany  
**Vice Programme Chair:** Andras Poppe, Budapest University of Technology & Economics, Hungary

**Steering Committee:**  
M. Rencz, Budapest University of Technology & Economics, Hungary (chair)  
B. Courtois, CMP, France  
J. Janssen, NXP Semiconductors, Nijmegen, The Netherlands  
A. Napieralski, TU Lodz, Poland  
J. Parry, Mentor Graphics, UK  
P. Raad, Southern Methodist University, Atlanta, USA  
A. Rubio, U. Politècnica de Catalunya, Spain  
B. Wunderle, Chemnitz University of Technology, Germany

Programme Committee:	
Name	Company
J . Altet	U. Politècnica de Catalunya, Spain
M. Abo Ras	Berliner Nanotest und Design GmbH, Germany
T. Baba	National Metrology Institute Tsukuba, Japan
I. Barsony	Institute for Technical Physics and Materials Science (MFA)
S. Bouwstra	MEMS Technical Consultancy, Amsterdam, The Netherlands
K. Chakrabarty	Duke University, Durham, USA
O. Chapuis	CIN2-CSIC, Barcelona, Spain
L. Codecasa	Politecnico di Milano, Italy
A. Daniel	Intel, USA
R. Egawa	Tohoku University, Japan
V. Eveloy	The Petroleum Inst., UAE
S. Garimella	Purdue University, West Lafayette, USA
Y. C. Gerstenmaier	Siemens, Germany

Name	Company
A. Glezer	The Georgia Institute of Technology, USA
A. Gupta	Freescale Semiconductor Inc., Austin, USA
J. Janssen	NXP Semiconductors, Nijmegen, The Netherlands
X. Jorda	Centro Nacional de Microelectronica, Spain
J. Keller	AMIC Angewandte Micro-Messtechnik GmbH, Germany
W. Luiten	Philips Applied Technologies, Eindhoven, The Netherlands
W. C. Maia	THALES-EPM, Meudon-la-Forêt, France
B. Michel	Fraunhofer Institute for Electronic Nanosystems ENAS, Germany
B. Michel	IBM Zurich, Rueschlikon, Switzerland
A. Napieralski	TU Lodz, Poland
H. Oppermann	Fraunhofer Institute for Reliability and Microintegration IZM, Germany
X. Perpina	Centro Nacional de Microelectrónica, Spain
T. Persoons	Purdue University, USA
P. Rodgers	The Petroleum Inst., UAE
A. Rubio	U. Politècnica de Catalunya, Spain
S. Sapatnekar	University of Minnesota, USA
R. Schacht	Brandenburg University of Technology, Cottbus-Senftenberg, Germany
D. Schweitzer	Infineon Technologies AG, Germany
Y. Scudeller	E.Polytech. U. Nantes, France
A. Shakouri	Purdue University, USA
E. Suhir	UC Santa Cruz, USA
A. Tay	NUS, Singapore
V. Tsoi	Huawei Technologies, Sweden
B. Vandevelde	IMEC, Belgium
S. Volz	Ecole Centrale Paris, France
G. Wachutka	TU München, Germany
J. Yu	Philips Research, The Netherlands
T. Zahner	OSRAM, Germany



GENERAL  
INFORMATION

GENERAL INFORMATION

CONFERENCE VENUE

The Conference will be held at the Fraunhofer-Forum Berlin, right in the center of the city.

FRAUNHOFER-FORUM BERLIN

Anna-Louisa-Karsch-Straße 2, 10178 Berlin, Germany  
www.forum.fraunhofer.de

HOW TO FIND YOUR WAY AROUND

We have booked the Fraunhofer-Forum's entire ground floor for the Therminic 2013 Workshop. The floor plan on page 10 and the session overviews are designed to help you find your way around. Coffee break and lunchtime catering will be offered on the ground floor in the exhibition and poster area.

WARDROBE AND BAGGAGE CHECK

Wardrobe and baggage check are available on the ground floor, next to the registration desk.

CONFERENCE REGISTRATION

The conference registration fee includes admission to all conference sessions and the poster session. The conference package includes a printed copy of the proceedings, a list of registered conference participants and authors, lunch and refreshments during breaks. Regular participants have free admission to the gala dinner. For accompanying persons extra tickets can be purchased for this event.

THE REGISTRATION DESK IS OPEN

Wednesday, September 25, 2013	08.00 am – 06.30 pm
Thursday, September 26, 2013	08.30 am – 06.30 pm
Friday, September 27, 2013	08.30 am – 03.00 pm

DOOR REGISTRATION FEES

Regular Workshop Participation: 750 EUR  
IEEE or Committee Member Workshop Participation: 690 EUR  
One-day Participation Special Sessions September 27, 2013: 290 EUR  
Gala Dinner // Spree River Cruise: 70 EUR

PAYMENT

The registration fee must be credited towards the conference account no later than September 20, 2013. All transfer charges must be covered by the participant's bank. If we have not received your payment September 20, 2013 you will have to pay at the conference.

CONTACT INFORMATION AND ASSISTANCE DURING THE CONFERENCE

Don't hesitate to approach us at the registration desk if you have any questions or requests. Our aim is to help you make the most of your conference participation.

DIETARY REQUIREMENTS

The rich buffet lunch is designed to cater for all dietary requirements and all tastes. When in doubt, please consult one of the chefs serving the food, they will be able to give you detailed information.

INTERNET ACCESS

The Fraunhofer-Forum kindly provides all conference delegates with wireless Internet access throughout the conference. Login-information is available at the registration counter.

Please remember to log out when not using the Internet in order to avoid jammed lines.

CONFERENCE LANGUAGE AND PROCEEDINGS

The official language of all presentations is English. The conference proceedings will be handed out at the registration desk upon check-in.



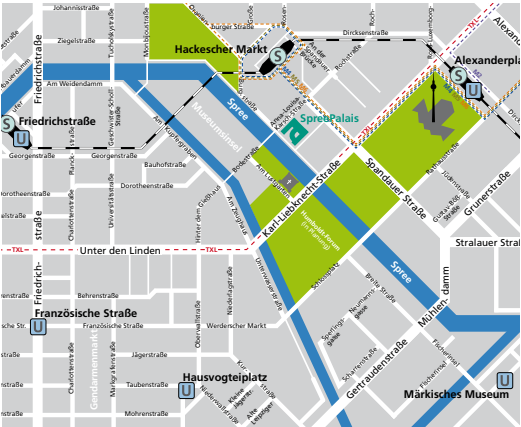
CONFERENCE  
VENUE

FRAUNHOFER-FORUM BERLIN  
@ SPREEPALAIS

Anna-Louisa-Karsch-Straße 2, 10178  
Berlin, Germany  
[www.forum.fraunhofer.de](http://www.forum.fraunhofer.de)

PUBLIC TRANSPORT

S-Bahn lines S 5, S 7, S 75, S 9 all stop at  
Hackescher Markt, a 2-minute-walk from  
the Fraunhofer Forum.



GROUND  
FLOOR

SPÉKTRUM  
Sessions 1-12

FOYER

Poster Area, Lunch and Coffee Break



1<sup>ST</sup> FLOOR

AUDITORIUM  
Special Sessions

CONFERENCE VENUE





## VENDOR COMPANIES

The organizers would like to express their thanks to the following companies for their support.

### MENTOR GRAPHICS

The Mechanical Analysis Division has led the market in electronics thermal design with software solutions for more than two decades and has the largest installed base of any tool provider. Mentor Graphics' FloTHERM®, and FloEFD™ suites of thermal simulation tools predict airflow, temperature and heat transfer in components, boards and complete systems, across all industries. These software solutions are complemented by a range of thermal characterization hardware that can measure the thermal resistances and capacitances in the heat flow path from the die junction to the ambient, identifying material properties and interfacial resistances to allow full thermal model verification.

#### CONTACT:

Mentor Graphics MicReD Division | Dr. Gabor Farkas

Gabor Denes utca 2. fszt 1/ (Infopark D) | Budapest, Hungary H-1117

Phone: +36 30 280 3752 | [Gabor\\_Farkas@mentor.com](mailto:Gabor_Farkas@mentor.com)

### INFRADEC GMBH

The Dresden-based company InfraTec GmbH Infrarotsensorik und Messtechnik is a specialist for products and services in the field of infrared technology. The business sector of infrared measuring technology operates in all areas of thermographic applications, with its scope of performance ranging from sales of thermographic cameras to the self-developed and manufactured high-end thermal camera series ImageIR®. Extensive detailed images of electrical assemblies and components with a pixel size of up to 2 µm can be generated with the aid of the 8-times microscope.

#### CONTACT:

InfraTec GmbH | Infrarotsensorik und Messtechnik

Gostritzer Str. 61 – 63 | 01217 Dresden, Germany

Phone: +49 351 871-8620 | [thermo@InfraTec.de](mailto:thermo@InfraTec.de) | [www.InfraTec.de](http://www.InfraTec.de)

### NANOTEST

The Berlin-based Nanotest und Design GmbH serves as a full-scale provider of engineering and testing services for reliability evaluation in microsystem technologies and nanotechnology. One main area of expertise is thermal characterization of materials, interfaces and components in microelectronics.

At THERMINIC 2013 Nanotest presents the TIMA Tester, a universal platform providing various modules for precise and reproducible thermal characterization (based on steady-state technique). All types of TIMs, substrates, isolation or high conductive die attach materials etc. can be investigated. Properties from thermal conductivity, thermal interface resistance etc. up to aging behavior can be analyzed.

#### CONTACT:

Berliner Nanotest und Design GmbH | Mohamad Abo Ras

Volmerstr. 9 B | 12489 Berlin, Germany

Phone: +49 30 6392 3880 | [aboras@nanotest.org](mailto:aboras@nanotest.org) | [www.nanotest.org](http://www.nanotest.org)





OVERVIEW

Wednesday, September 25, 2013

Registration

🕒 8.00 am – 9.00 am

Welcome

🕒 9.00 am – 9.10 am

**Keynote I:**

Thermal Challenges for Microprocessors and  
High Performance Computing

*Thomas Brunschwiler, IBM Research*

*Chair: Peter E. Raad, SMU*

🕒 9.10 am – 9.50 am

➔ **Session 1:**

**Thermal Phenomena on the Nano Scale**

🕒 9.50 am – 11.10 am

Coffee Break

🕒 11.10 am – 11.40 am

➔ **Session 2:**

**Design and Simulation I**

🕒 11.40 am – 12.40 pm

Lunch

🕒 12.40 pm – 2.10 pm

➔ **Session 3:**

**Characterization**

🕒 2.10 pm – 3.10 pm

Coffee Break

🕒 3.10 pm – 3.40 pm

➔ **Session 4:**

**Thermal (Interface) Materials**

🕒 3.40 pm – 4.40 pm

Coffee Break

🕒 4.40 pm – 5.10 pm

Poster Introduction Session

🕒 5.10 pm – 6.30 pm

Poster Session & Cocktails

🕒 6.30 pm – 8.00 pm

SESSIONS 1 – 2

Session 1:  
Thermal Phenomena on the Nano Scale

🕒 9.50 am – 11.10 am

SPEKTRUM

➔ Chairs: P-Olivier Chapuis, Lorenzo Codecasa

9.50 am    **Nanoscale Thermal Transport And Phonon Dynamics In Ultra-Thin Si Based Nanostructures**

Markus R. Wagner<sup>1</sup>, Emigdio Chávez-Ángel<sup>1,2</sup>, Jordi Gomis-Bresco<sup>1</sup>, Juan Sebastian Reparaz<sup>1</sup>, Andrey Shchepetov<sup>3</sup>, Mika Prunnila<sup>3</sup>, Jouni Ahopelto<sup>3</sup>, Francesc Alzina<sup>1</sup>, Clivia M. Sotomayor-Torres<sup>1,2,4</sup>

<sup>1</sup>Institute of Nanotechnology (ICN), Campus UAB, Barcelona, Spain; <sup>2</sup>Dept. of Physics, Campus UAB, Barcelona, Spain; <sup>3</sup>VTT Technical Research Centre of Finland, Espoo, Finland; <sup>4</sup>Catalan Institution for Research and Advanced Studies (ICREA), Barcelona, Spain

10.10 am    **Investigation of High Gigahertz Acoustic Phonon Lifetimes in Thin Silicon Membranes**

Martin Schubert, Martin Grossmann, Matthias Klingele, Oliver Ristow, Mike Hettich, Thomas Dekorsy  
Department of Physics, University of Konstanz, Germany

10.30 am    **Investigation of the Thermal Behavior of Thin Crystalline Silcon Solar Cells**

Balázs Plesz, Sándor Ress  
Budapest University of Technology and Economics, Hungary

10.50 am    **The Nondestructive Thermoacoustic Method of Determination of the Air-Tightness of Metal Packagings of Transistors**

Maciej Kubicki, Mirosław Maliński  
Koszalin University of Technology, Poland

Session 2:  
Design and Simulation I

🕒 11.40 am – 12.40 pm

SPEKTRUM

➔ Chairs: Gerhard Wachutka, John David Parry

11.40 am    **Multiphysics Modelling for Power Electronics Modules – Current Status and Future Challenges**

Chris John Bailey  
University of Greenwich, United Kingdom

12.00 pm    **Stochastic Thermal Modeling by Polynomial Chaos Expansion**

Lorenzo Codecasa, Luca Di Rienzo  
Politecnico di Milano, Italy

12.20 pm    **Electro-Thermal Co-Design of Chip-Package-Board-Systems**

Christoph Sohrmann, Andy Heinig, Michael Dittrich, Roland Jancke, Peter Schneider  
Fraunhofer IIS/EAS, Dresden, Germany

## SESSIONS 3 – 4

### Session 3: Characterization

🕒 2.10 pm – 3.10 pm

SPEKTRUM

➔ Chairs: Peter Gabor Szabo, Carl Zandén

#### 2.10 pm Toolset for Measuring Thermal Behavior of FPGA Devices

Paweł Weber<sup>1</sup>, Maciej Zagrabski<sup>1</sup>, Bartosz Wojciechowski<sup>1</sup>, Krzysztof S. Berezowski<sup>1</sup>, Maciej Nikodem<sup>1</sup>, Krzysztof Kępa<sup>2</sup>

<sup>1</sup>Wrocław University of Technology, Poland; <sup>2</sup>Virginia Tech, Blacksburg, Virginia, USA

#### 2.30 pm Thermal Conductivity Measurements with the 3omega Method and Scanning Thermal Microscopy

Wassim Jaber, Ali Assy, Stéphane Lefèvre, Séverine Gomès, P-Olivier Chapuis  
Centre for Thermal Sciences (CETHIL), CNRS - INSA Lyon, France

#### 2.50 pm Thermal Conductivity of Isotopically Enriched Silicon Carbide

Björn Lundqvist<sup>1</sup>, Peter E. Raad<sup>3,4</sup>, Milan Yazdanfar<sup>1</sup>, Pontus Stenberg<sup>1</sup>, Rickard Liljedahl<sup>1</sup>, Pavel L. Komarov<sup>4</sup>, Niklas Rorsmann<sup>2</sup>, Joel Ager III<sup>5</sup>, Olle Kordina<sup>1</sup>, Ivan Ivanov<sup>1</sup>, Erik Janzén<sup>1</sup>

<sup>1</sup>Linköping University, Sweden; <sup>2</sup>Chalmers University of Technology, Gothenburg, Sweden; <sup>3</sup>Southern Methodist University, Dallas, Texas, USA; <sup>4</sup>TMX Scientific, Dallas, Texas, USA; <sup>5</sup>Lawrence Berkeley National Labs, Berkeley, California, USA

### Session 4: Thermal (Interface) Materials

🕒 3.40 pm – 4.40 pm

SPEKTRUM

➔ Chairs: Anna Ellett, Daniel May

#### 3.40 pm Polymers in Power Electronics – Performance of Thermal Interface Materials

André Zimmermann, Klaus-Volker Schuett  
Robert Bosch GmbH, Germany

#### 4.00 pm Development and Fabrication of Thin Film Thermo Test Chips and its Integration into a Test System for Thermal Interface Characterization

Mohamad Abo Ras<sup>1,2</sup>, Gunter Engelmann<sup>3</sup>, Daniel May<sup>5</sup>, Mario Rothermund<sup>3</sup>, Ralph Schacht<sup>2,4</sup>, Bernhard Wunderle<sup>2,5</sup>, Thomas Winkler<sup>1</sup>, Bernd Michel<sup>2</sup>, Hermann Oppermann<sup>3</sup>

<sup>1</sup>Berliner Nanotest und Design GmbH, Berlin, Germany; <sup>2</sup>Fraunhofer ENAS, Chemnitz, Germany; <sup>3</sup>Fraunhofer IZM, Berlin, Germany; <sup>4</sup>Brandenburg University of Technology, Cottbus-Senftenberg, Germany; <sup>5</sup>Chemnitz University of Technology, Germany

#### 4.20 pm Effect of Nanostructuring on the Thermal Conductivity of Thermoelectric Materials

Stéphane Grauby<sup>1</sup>, Etienne Puyoo<sup>2</sup>, Miguel Munoz Rojo<sup>3</sup>, Marisol Martin Gonzalez<sup>3</sup>, Wilfrid Claeys<sup>1</sup>, Stefan Dilhaire<sup>1</sup>

<sup>1</sup>Université Bordeaux 1, France; <sup>2</sup>INSA, Lyon, France; <sup>3</sup>IMM-CSIC, Madrid, Spain



POSTER SESSION

Poster Introduction Session

🕒 5.10 pm – 6.30 pm

SPEKTRUM

➔ Chairs: Marta Rencz, András Poppe

01 The Effect of Heat Treatment on Spin-On Oxide Glasses in Solar Cell Application

Enikő Bándy, Árpád Földváry, Márta Dr. Rencz  
*Budapest University of Technology and Economics, Hungary*

02 Thermal Model Generalization of Infrared Radiation Sensors

György Bognár, Péter Gábor Szabó  
*Budapest University of Technology and Economics, Hungary*

03 Self-Heating Effects in Nano-Scale SOI MOSFETs: TCAD and Molecular Dynamics Simulations

Alex Burenkov<sup>1</sup>, Viktor Belko<sup>2</sup>, Juergen Lorenz<sup>1</sup>  
*<sup>1</sup>Fraunhofer IISB, Erlangen, Germany; <sup>2</sup>Belarussian State University, Minsk, Belarus*

04 Compact Electro-Thermal Models of Interconnects

Lorenzo Codecasa  
*Politecnico di Milano, Italy*

05 Investigation of DELPHI Compact Thermal Model Style for Modeling Surface-Mounted Soft Magnetic Composite Inductor

Cheikh Tidiane Dia<sup>1,2</sup>, Eric Monier-Vinard<sup>1</sup>, Najib Laraq<sup>2</sup>, Valentin Bissuel<sup>1</sup>  
*<sup>1</sup>Thales Global Services, Meudon-La-Forêt, France; <sup>2</sup>Université Paris Ouest, Laboratoire Thermique Interfaces Environnement, France*

06 Thermal Characterization of Multichip Structures

Ferenc Ender<sup>1</sup>, Gusztav Hantos<sup>1</sup>, Dirk Schweitzer<sup>2</sup>, Peter Gabor Szabo<sup>1</sup>  
*<sup>1</sup>Budapest University of Technology and Economics, Hungary; <sup>2</sup>Infineon Technologies AG, Neubiberg, Germany*

07 The Compact Thermal Model of the Pulse Transformer

Krzysztof Górecki, Małgorzata Rogalska  
*Gdynia Maritime University, Poland*

08 Heat Flux Sensor for Power Loss Measurements of Switching Devices

Demetrio Iero<sup>1</sup>, Francesco G. Della Corte<sup>1</sup>, Giuseppe Fiorentino<sup>2</sup>, Pasqualina M. Sarro<sup>2</sup>, Bruno Morana<sup>2</sup>  
*<sup>1</sup>Università Mediterranea Reggio Calabria, Italy; <sup>2</sup>Delft University of Technology, The Netherlands*

09 Empirical Feasibility Assessment of Energy Scavenging Opportunity in Compact Mobile Computers

Muhammad Azhar Ali Khan, Ali Muhtaroglu  
*Middle East Technical University - Northern Cyprus Campus, Turkey*

10 Non-linear Thermal Simulations of Semiconductor Devices on System Level

Vladimír Košel<sup>1</sup>, Monica Schipani<sup>2</sup>, Ehrenfried Seebacher<sup>1</sup>  
*<sup>1</sup>ams AG, Unterpremstaetten, Austria; <sup>2</sup>ams Italy Srl, Navacchio, Italy*

POSTER SESSION

11 **Proposal of New Thermal Resistance for Light-Emitting Diodes**

Byungjin Ma<sup>1</sup>, Kwanhoon Lee<sup>2</sup>

<sup>1</sup>*Korea Electronics Technology Institute, Seongnam, Korea, Republic of (South Korea);*

<sup>2</sup>*Kwangwoon University, Seoul, Korea, Republic of (South Korea)*

12 **Combined Method for Thermal Characterization of High Power Semiconductors**

Enrico Merten<sup>1</sup>, Mohamad Abo Ras<sup>1</sup>, Tobias von Essen<sup>1</sup>, Ralph Schacht<sup>2</sup>, Daniel May<sup>3</sup>,

Thomas Winkler<sup>1</sup>, Bernd Michel<sup>4</sup>

<sup>1</sup>*Berliner Nanotest & Design GmbH, Berlin, Germany;* <sup>2</sup>*Brandenburg University of Technology, Cottbus-Senftenberg, Germany;* <sup>3</sup>*Chemnitz University of Technology, Germany;*

<sup>4</sup>*Fraunhofer ENAS, Chemnitz, Germany*

13 **Thermal-Electronic Integrated Logic**

János Mizsei<sup>1</sup>, Jyrki Lappalainen<sup>2</sup>, Márton C. Bein<sup>1</sup>

<sup>1</sup>*Budapest University of Technology and Economics, Hungary;* <sup>2</sup>*University of Oulu, Finland*

14 **Approach For Reliability of Thermal Interface Materials In Battery Cell Sensors**

Torsten Nowak<sup>1</sup>, Matthias Müller<sup>1</sup>, Felix Wüst<sup>1</sup>, Michael Krüger<sup>1</sup>, Ole Hölck<sup>1</sup>, Hans

Walter<sup>1</sup>, Olaf Wittler<sup>1</sup>, Klaus-Dieter Lang<sup>1,2</sup>

<sup>1</sup>*Fraunhofer IZM, Berlin, Germany;* <sup>2</sup>*Technical University Berlin, Germany*

15 **Low Voltage Fully Integrated DC-DC Converter for Self-Powered Temperature Sensors**

Manula Randhika Pathirana, Ali Muhtaroğlu

*Middle East Technical University Northern Cyprus Campus, Turkey*

16 **Single Kernel Electro-Thermal IC Simulator**

Philippe Raynaud

*Mentor Graphics, Montbonnot Saint Martin, France*

17 **SrTiO3 Thin Films as Highly Efficient Thermoelectric Materials**

Juan Sebastian Reparaz<sup>1</sup>, Sweta Bhansali<sup>1</sup>, Worawut Khunsin<sup>1</sup>, Markus R. Wagner<sup>1,4</sup>,

Jaume Roqueta<sup>2</sup>, Jose Santiso<sup>2</sup>, Begona Abad Mayor<sup>3</sup>, Pablo Diaz-Chao<sup>3</sup>, Marisol

Martin-Gonzalez<sup>3</sup>, Clivia M. Sotomayor Torres<sup>1</sup>

<sup>1</sup>*Catalan Institute of Nanotechnology, Barcelona, Spain;* <sup>2</sup>*Centre d'Investigació en Nanociència i nanotecnologia (CIN2), Barcelona, Spain;* <sup>3</sup>*Instituto de Microelectronica de Madrid, Spain;* <sup>4</sup>*Catalan Institute for Research and Advanced Studies ICREA, Spain*

18 **Electronics Cooling By Extended Surface: Refractive Index Changes Flow Visualization of the Natural Convection Heat Transfer**

Carmine Sapia, G. Sozio

*University Roma TRE, Italy*

19 **Parametric Transient Thermo-Electrical PSPICE-Model for a Power Cable**

Ralph Schacht<sup>1,2,3</sup>, Sven Rzepka<sup>2,3</sup>, Bernd Michel<sup>2,3</sup>

<sup>1</sup>*Brandenburg University of Technology, Cottbus-Senftenberg,, Germany;* <sup>2</sup>*Fraunhofer ENAS, Chemnitz, Germany;* <sup>3</sup>*Joint Lab Berlin – Technical Safety, Germany*

20 **Characterization and Kinetic Monitoring of the Reactions between TixAl<sub>y</sub> Phases in Ti-Al based Ohmic Contacts on n-type GaN by Differential Scanning Calorimetry**

Nicolas Thierry-Jebali<sup>1,2</sup>, Rodica Chiriac<sup>1</sup>, Christian Brylinski<sup>1</sup>

<sup>1</sup>*Université de Lyon, Laboratoire des Multimatériaux et Interfaces, Villeurbanne, France;*

<sup>2</sup>*INSA de Lyon, Laboratoire Ampère, Villeurbanne, France*

## POSTER SESSION

### 21 Logi-Thermal Simulation Using High-Resolution Temperature Dependent Delay Models

Andras Timar, Marta Rencz

*Budapest University of Technology and Economics, Hungary*

### 22 In-Situ Measurements of Material Thermal Parameters for Accurate LED Lamp Thermal Modelling

Miquel Vellvehi<sup>1</sup>, Xavier Perpinyà<sup>1</sup>, Xavier Jordà<sup>1</sup>, Robert J Verkhoven<sup>2</sup>, Jos M. G. Kunen<sup>2</sup>, Jiri Jakovenko<sup>3</sup>, Peter Bancken<sup>4</sup>, Pieter J. Bolt<sup>2</sup>

*<sup>1</sup>Institut de Microelectrònica de Barcelona (IMB-CNM,CSIC), Spain; <sup>2</sup>TNO, Eindhoven, the Netherlands; <sup>3</sup>Czech Technical University in Prague, Czech Republic; <sup>4</sup>Philips Lighting, Eindhoven, The Netherlands*

### 23 Analysis of Effectiveness of Core Swapping in Modern Multicore Processors

Piotr Zajac, Michal Szermer, Marcin Janicki, Cezary Maj, Piotr Pietrzak, Andrzej Napieralski

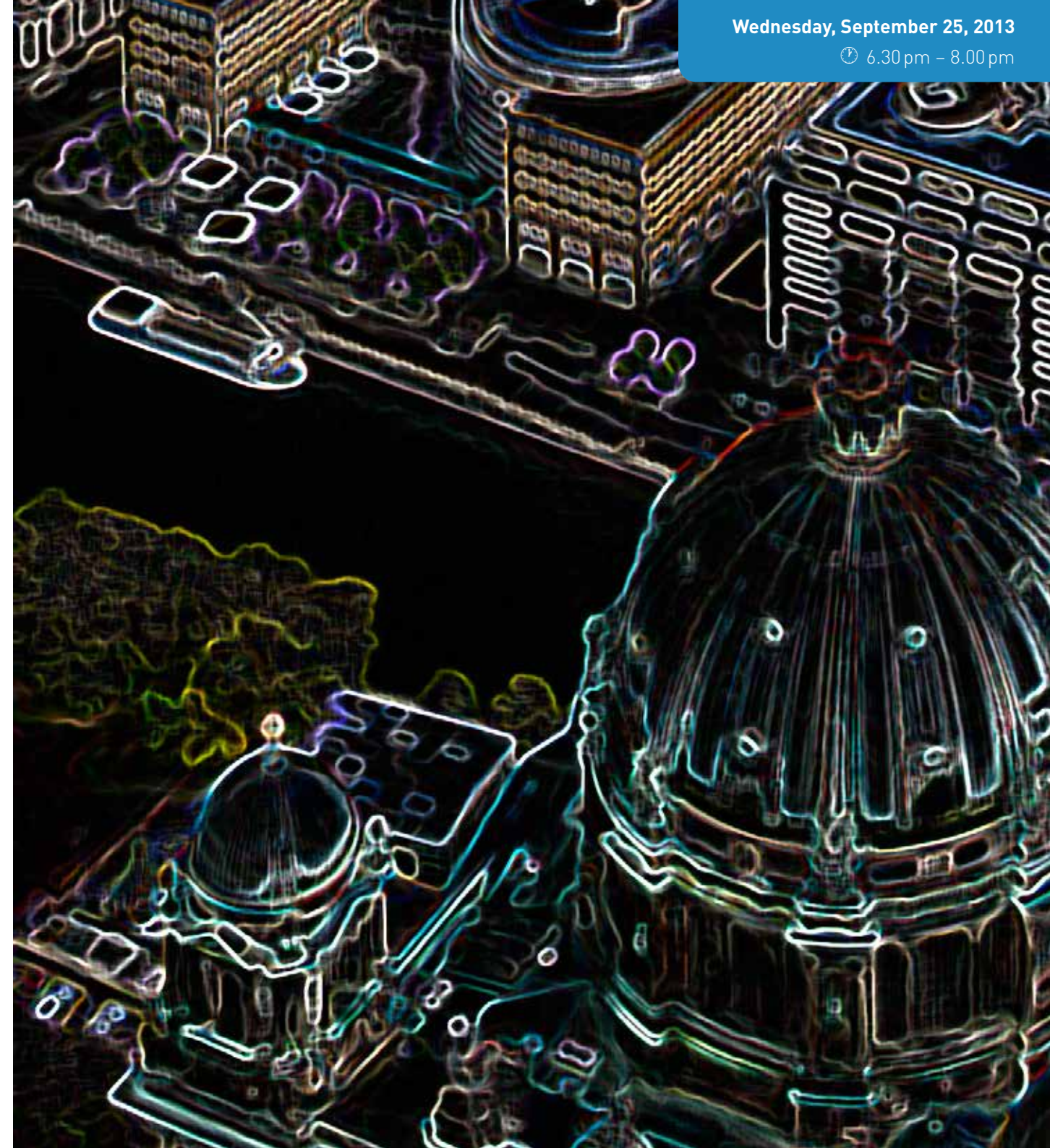
*Lodz University of Technology, Poland*

## Poster Session & Cocktails

🕒 6.30 pm – 8.00 pm

FOYER

→ Chairs: Marta Rencz, András Poppe







SESSIONS 6 – 7

Session 6:  
Thermal Metrology

🕒 9.40 am – 11.00 am

SPEKTRUM

➔ Chairs: Mohamad Abo Ras, Torsten Nowak

- 09.40 am

**Transient Thermal Techniques as Failure Analytical Tool**  
Daniel May<sup>1</sup>, Bernhard Wunderle<sup>1</sup>, Ralph Schacht<sup>2</sup>  
<sup>1</sup>Chemnitz University of Technology, Germany; <sup>2</sup>Brandenburg University of Technology, Cottbus-Senftenberg, Germany
- 10.00 am

**Practical Aspects of Thermal Transient Testing in Live Digital Circuits**  
Gergely Nagy, Péter Horváth, András Poppe  
Budapest University of Technology and Economics, Hungary
- 10.20 am

**Improving the Accuracy of Junction Temperature Measurement with the Square-Root-t Method**  
Christian Herold<sup>1</sup>, Menia Beier<sup>1</sup>, Josef Lutz<sup>1</sup>, Alexander Hensler<sup>2</sup>  
<sup>1</sup>Chemnitz University of Technology, Germany; <sup>2</sup>SIEMENS AG, Erlangen, Germany
- 10.40 am

**Thermal Conductivity Reduction in Si Free-Standing Membranes Investigated Using Raman Thermometry**  
Markus R. Wagner<sup>1</sup>, Juan Sebastian Reparaz<sup>1</sup>, Emigdio Chávez-Ángel<sup>1,2</sup>, Jordi Gomis-Bresco<sup>1</sup>, Andrey Shchepetov<sup>3</sup>, Mika Prunnila<sup>3</sup>, Jouni Ahopelto<sup>3</sup>, Francesc Alzina<sup>1</sup>, Clivia M. Sotomayor Torres<sup>1,4</sup>  
<sup>1</sup>Catalan Institute of Nanotechnology, Barcelona, Spain; <sup>2</sup>Dept. of Physics, UAB, Barcelona, Spain; <sup>3</sup>VTT Technical Research Centre of Finland, Finland; <sup>4</sup>Institució Catalana de Recerca i Estudis Avançats (ICREA), Barcelona, Spain

Session 7:  
Reliability

🕒 11.30 am – 1.10 pm

SPEKTRUM

➔ Chairs: Wendy Luiten, Jürgen Keller

- 11.30 am

**Solder Joint Lifetime of Rapid Cycled LED Components**  
Wendy Luiten  
Philips Research, Eindhoven, The Netherlands
- 11.50 am

**Mean-Time-to-Crack Model of Microbump Interconnect in FCGBA Package under Thermal Cyclic Test**  
Chien-Chang Chen<sup>1</sup>, Wei-Chen Wu<sup>2</sup>, Ching Yu Chin<sup>2</sup>, Hung-Ming Chen<sup>2</sup>, Vito Lin<sup>3</sup>, Eason Chen<sup>3</sup>  
<sup>1</sup>National Chiao Tung University, Taiwan, R.O.C.; <sup>2</sup>VLSI Design Automation Laboratory, National Chiao Tung University, HsinChu City, Taiwan, R.O.C.; <sup>3</sup>Siliconware Precision Industries Co., Taiwan, R.O.C.
- 12.10 pm

**Stress Impact of Thermal-Mechanical Loads Measured with the Stress Chip**  
Florian Schindler-Saefkow<sup>1,2,4</sup>, Florian Rost<sup>1</sup>, Alexander Otto<sup>1,4</sup>, Jürgen Keller<sup>2</sup>, Thomas Winkler<sup>4</sup>, Bernhard Wunderle<sup>3,1</sup>, Bernd Michel<sup>1</sup>, Sven Rzepka<sup>1,4</sup>  
<sup>1</sup>Fraunhofer ENAS, Chemnitz, Germany; <sup>2</sup>AMIC Angewandte Micro-Messtechnik GmbH, Berlin, Germany; <sup>3</sup>Chemnitz University of Technology, Germany; <sup>4</sup>Berliner Nanotest and Design GmbH, Berlin, Germany
- 12.30 pm

**Optimisation of Low Dissipation Micro-Hotplates – Thermo-Mechanical Design and Characterisation**  
Ferenc Bíró<sup>1,2</sup>, Andrea Edit Pap<sup>2</sup>, Csaba Dücso<sup>2</sup>, István Bársony<sup>2</sup>  
<sup>1</sup>Doctoral School of Molecular & Nanotechnologies, University of Pannonia, Veszprém, Hungary; <sup>2</sup>Research Centre of Natural Science, Research Institute for Technical Physics and Materials Science, Budapest, Hungary
- 12.50 pm

**Lifetime of CMOS Circuits Evaluation by Means of Electro-Thermal Simulations**  
Maroua Garci, Jean-Baptiste Kammerer, Luc Hébrard  
ICube, Strasbourg, France

SESSIONS 8 – 9

Session 8:  
Thermal Management Concepts

🕒 2.40 pm – 4.00 pm

SPEKTRUM

➔ Chairs: Bernhard Wunderle, Ralph Schacht

- 2.40 pm Double-Sided Cooling and Thermo-Electrical Management of Power Transients for Silicon Chips on DCB-Substrates for Converter Applications: Design, Technology and Test**  
Bernhard Wunderle<sup>1</sup>, Charles-Alix Manier<sup>2</sup>, Mohamad Abo Ras<sup>3</sup>, Martin Spring-born<sup>1</sup>, Daniel May<sup>1</sup>, Hermann Oppermann<sup>2</sup>, Michael Toepper<sup>2</sup>, Raul Mrossko<sup>4</sup>, T. Xhonneux<sup>5</sup>, Tristan Caroff<sup>6</sup>, Wilhelm Maurer<sup>7</sup>, Radoslava Mitova<sup>8</sup>  
<sup>1</sup>Chemnitz University of Technology, Germany; <sup>2</sup>Fraunhofer IZM, Berlin, Germany; <sup>3</sup>Berliner Nanotest und Design GmbH, Berlin, Germany; <sup>4</sup>AMIC Angewandte Micro-Messtechnik GmbH, Berlin, Germany; <sup>5</sup>TAIPRO Engineering, Seraing, Belgium; <sup>6</sup>CEA, Grenoble, France; <sup>7</sup>Infineon, Munich, Germany; <sup>8</sup>Schneider Electric, Grenoble, France
- 3.00 pm Thermal Management Challenges in the Passive Cooling of Handheld Devices**  
Guy Robert Wagner, William Maltz  
Electronic Cooling Solutions, Santa Clara, California, USA
- 3.20 pm Power and Thermal Constraints of Modern System-on-a-Chip Computer**  
Efraim Rotem<sup>1,2</sup>, Ran Ginosar<sup>2</sup>, Uri Weiser<sup>2</sup>, Avi Mendelson<sup>2</sup>  
<sup>1</sup>Intel Corporation, Haifa, Israel; <sup>2</sup>Technion, Israel Institute of Technology, Israel
- 3.40 pm Experimental Investigation of Uninterrupted and Interrupted Microchannel Heat Sinks**  
Ayse Gozde Ulu Soysal<sup>1</sup>, Cuneyt Sert<sup>2</sup>, Almila Guvenc Yazicioglu<sup>2</sup>  
<sup>1</sup>Aselsan A.S., Turkey; <sup>2</sup>Middle East Technical University, Ankara, Turkey

Session 9:  
Design and Simulation II

🕒 4.30 pm – 5.30 pm

SPEKTRUM

➔ Chairs: Chris John Bailey, Marcin Janicki

- 4.30 pm Convolution Based Compact Thermal Model for 3D-ICs: Methodology and Accuracy Analysis**  
Federica Lidia Teresa Maggioni<sup>1,2</sup>, Herman Oprins<sup>1</sup>, Eric Beyne<sup>1</sup>, Ingrid De Wolf<sup>1,3</sup>, Tine Baelmans<sup>2</sup>  
<sup>1</sup>IMEC, Leuven, Belgium; <sup>2</sup>KULeuven, Leuven, Belgium; <sup>3</sup>KULeuven, Leuven, Belgium
- 4.50 pm Dynamic Sub-Compact Model and Global Compact Model Reduction for Multichip Components**  
Cheikh Tidiane Dia<sup>1,2</sup>, Eric Monier-Vinard<sup>1</sup>, Najib Laraq<sup>2</sup>, Valentin Bissuel<sup>1</sup>, Olivier Daniel<sup>1</sup>  
<sup>1</sup>Thales Global Services, Meudon La Foret, France; <sup>2</sup>Laboratoire Thermique Interfaces Environnement (LTIE), Paris, France
- 5.10 pm Novel Approach to Compact Modeling for Nonlinear Thermal Conduction Problems**  
Lorenzo Codecasa  
Politecnico di Milano, Italy



SCHEDULE

Vendors' Session

🕒 5.30 pm – 6.00 pm

SPEKTRUM

FOYER

➔ Chair: Peter E. Raad

The three exhibiting companies Mentor Graphics, Infratec and Nanotest will each give a ten-minute presentation on their services and equipment.

Social Event: Boat Tour on the MS BELVEDERE

🕒 8.00 pm – 11.00 pm

The planned 3-hour-tour links historical and modern Berlin and offers another perspective of the city! On board the ships, a guide explain the well-known and less-known sights of Berlin and make them more familiar with a wealth of intriguing information and anecdotes.

Departure from FFB 7.00 pm

Ship boarding time 7.30 pm

Ship departure time 8.00 pm

Address Märkisches Ufer, 10179 Berlin

Mobile number +49 163 97 28 653

From FFB, the ship jetty can be reached on foot. We will start our short walk (1.5 km, about 20 min.) leaving FFB at 7.00pm sharp. If you want to make your own way to the jetty, we will be happy to provide you with a map at the registration counter.

The Spree trip will take us through the city passing Mühlendamm Schleuse, Nikolai Quarter, Berlin Cathedral, Museum Island, Friedrichstrasse, Reichstag, Jakob-Kaiser-Haus, Marie-Elisabeth-Lüders-Haus, Paul-Loebe-Haus, Chancellor's Office, House of Cultures of the World, Moabit Werder, Bellevue Castle, the German Federal Ministry of the Interior, Castle Bridge with view of the Charlottenburg Castle and back again.



OVERVIEW

Friday, September 27, 2013

**Keynote III:**  
Thermal Challenges for Solid State Lighting  
*Theo Treurniet, Philips Lighting*  
*Chair: Bernard Courtois, CMP*  
🕒 9.00 am – 9.40 am

➔ **Session 10:**  
**Solid State Lighting / LED**  
🕒 9.40 am – 11.20 am

Coffee Break  
🕒 11.20 am – 11.50 am

➔ **Session 11:**  
**Power Electronics**  
🕒 11.50 am – 1.10 pm

Lunch  
🕒 1.10 pm – 2.40 pm

➔ **Session 12:**  
**Fluidics**  
🕒 2.40 pm – 3.40 pm

Closing Remarks  
🕒 3.40 pm – 3.50 pm

➔ **Special Session 1:**  
**Smart Power**  
🕒 9.40 am – 11.20 am

➔ **Special Session 2:**  
**Nanotherm**  
🕒 11.50 am – 1.10 pm

SESSION 10  
SPECIAL SESSION 1

Session 10:  
Solid State Lighting / LED

🕒 9.40 am – 11.20 am

SPEKTRUM

➔ Chairs: Thomas Zahner, Joan H. Yu

9.40 am Inline Rth Control: Fast Thermal Transient Evaluation for High Power LEDs

Thomas Dannerbauer, Thomas Zahner  
*Osram Opto Semiconductors GmbH, Regensburg, Germany*

10.00 am Improving Thermal Conductivity of Polymer Composites in Embedded LEDs Systems

Joan H. Yu, Giovanni Cennini  
*Philips Research, Eindhoven, The Netherlands*

10.20 am Study on Thermal Performance of High Power LED Employing Aluminium Filled Epoxy Composite as Thermal Interface Material

Anithambigai Permal<sup>1</sup>, Shanmugan Subramani<sup>1</sup>, Mutharasu Devarajan<sup>1</sup>, Thomas Zahner<sup>2</sup>, David Lacey<sup>3</sup>  
<sup>1</sup>*Universiti Sains Malaysia, Malaysia;* <sup>2</sup>*OSRAM Opto Semiconductors GmbH, Germany;*  
<sup>3</sup>*OSRAM Opto Semiconductors (Malaysia) Sdn. Bhd., Malaysia*

10.40 am The Influence of Mutual Thermal Interactions between Power LEDs on their Characteristics

Krzysztof Górecki  
*Gdynia Maritime University, Poland*

11.00 am Influence of Different Characterization Parameters on the Accuracy of LED Board Thermal Models for Retrofit Bulbs

Xavier Jorda<sup>1</sup>, Xavier Perpiñá<sup>1</sup>, Miquel Vellvehi<sup>1</sup>, Wim Hertog<sup>2</sup>, Mariano Peralvarez<sup>2</sup>, Josep Carreras<sup>2</sup>  
<sup>1</sup>*IMB-CNM(CSIC), Spain;* <sup>2</sup>*IREC, Spain*

Special Session 1:  
Smart Power

🕒 9.40 am – 11.20 am

AUDITORIUM

➔ Chairs: Jens Heilmann, Yifeng Fu

9.40 am Free Standing Thermal Interface Material based on Vertical Arrays Composites

Elodie Leveugle, Laurent Divay, Hung Le Khanh, Joffrey Daon, Evelyne Chastaing, Pierre Le Barny, Afshin Ziaei  
*Thales Research and Technology, Palaiseau, France*

10.00 am Controlling the Density of CNTs by Different Underlayer Materials in PECVD Growth

Liang Xu<sup>1,2</sup>, Di Jiang<sup>1</sup>, Yifeng Fu<sup>3</sup>, Shantung Tu<sup>2</sup>, Johan Liu<sup>1,4</sup>  
<sup>1</sup>*Chalmers University of Technology, Gothenburg, Sweden;* <sup>2</sup>*East China University of Science and Technology, China;* <sup>3</sup>*SHT Smart High Tech AB, Gothenburg, Sweden;* <sup>4</sup>*Shanghai University, China*

10.20 am Transient Cooling of Power Electronic Devices Using Thermoelectric Coolers Coupled with Phase Change Materials

Tristan Caroff<sup>1</sup>, Radoslava Mitova<sup>2</sup>, Julia Simon<sup>1</sup>, Bernhard Wunderle<sup>3</sup>  
<sup>1</sup>*CEA, Grenoble, France;* <sup>2</sup>*Schneider Electric, Grenoble, France;* <sup>3</sup>*Chemnitz University of Technology, Germany*

10.40 am Novel High Sensitivity Sensor Structures for Temperature Monitoring of GAN based MMICs

Alexandru Müller<sup>1</sup>, George Konstantinidis<sup>2</sup>, Adrian Dinescu<sup>1</sup>, Valentin Buiculescu<sup>1</sup>, Alexandra Stefanescu<sup>1</sup>, Alina Cismaru<sup>1</sup>, Ioana Giangu<sup>1</sup>, George Stavriniadis<sup>2</sup>, Antonis Stavriniadis<sup>2</sup>, Afshin Ziaei<sup>3</sup>  
<sup>1</sup>*IMT Bucharest, Romania;* <sup>2</sup>*FORTH-IESL-MRG Heraklion, Greece;* <sup>3</sup>*Thales Research & Technology, France*

11.00 am Failure Prediction of IGBT Modules Based on Power Cycling Tests

Zoltán Sárkány, András Vass-Várnai, Gusztáv Hantos, Márta Rencz  
*Budapest University of Technology and Economics, Hungary*



SESSION 11  
SPECIAL SESSION 2

Session 11:  
Power Electronics

🕒 11.50 pm – 1.10 pm

SPEKTRUM

➔ Chairs: John Janssen, Enrico Merten

11.50 am Impact of Nonlinearities in Boundary Conditions on Device Compact Thermal Models

Marcin Janicki<sup>1</sup>, Tomasz Torzewicz<sup>1</sup>, Andras Vass-Varnai<sup>2</sup>, Andrzej Napieralski<sup>1</sup>

<sup>1</sup>Lodz University of Technology, Poland; <sup>2</sup>Mentor Graphics, Budapest, Hungary

12.10 am Thermal Design of a High Current Circuit Board for Automotive Applications

Raúl Mroßko<sup>1</sup>, Thomas Hofmann<sup>2</sup>, Christoph Neeb<sup>3</sup>, Alexander Neimann<sup>4</sup>, Jürgen Keller<sup>1</sup>

<sup>1</sup>AMIC Angewandte Micro-Messtechnik GmbH, Germany; <sup>2</sup>Conti Temic Microelectronics GmbH, Nürnberg, Germany; <sup>3</sup>RWTH Aachen University, Germany; <sup>4</sup>Schweizer Electronic AG, Schramberg, Germany

12.30 pm Fully-Coupled 3D Electro-Thermal Field Simulator for Chip-Level Analysis of Power Devices

Wim Schoenmaker<sup>1</sup>, Olivier Dupuis<sup>1</sup>, Bart De Smedt<sup>1</sup>, Peter Meuris<sup>1</sup>, Jiri Ocenasek<sup>1</sup>, Wim Verhaegen<sup>1</sup>, Dündar Dumlugöl<sup>1</sup>, Martin Pfost<sup>2</sup>

<sup>1</sup>Magwel NV, Leuven, Belgium; <sup>2</sup>Reutlingen University, Germany

12.50 pm Generation of Electro-Thermal Models of Integrated Power Electronics Modules Using a Novel Synthesis Technique

Giuseppe Greco<sup>1</sup>, Giovanni Vinci<sup>1</sup>, Angelo Raciti<sup>2</sup>, Davide Cristaldi<sup>2</sup>

<sup>1</sup>STMicroelectronics, Catania, Italy; <sup>2</sup>Department of Electric Electronic and Systems Engineering, University of Catania, Italy

Special Session 2:  
Nanotherm

🕒 11.50 am – 1.10 pm

AUDITORIUM

➔ Chairs: Elodie Leveugle, Johan Liu

11.50 am Integrating Advanced Interconnect Technologies in a High Power Lighting Application: First Steps

Sander Noijen<sup>1</sup>, Sebastian Fritsche<sup>2</sup>, Andreas Steffen Klein<sup>2</sup>, Andras Poppe<sup>3</sup>, Gerard Kums<sup>1</sup>, Olaf van der Sluis<sup>1</sup>

<sup>1</sup>Philips Research, Eindhoven, The Netherlands; <sup>2</sup>Heraeus Materials Technology GmbH & Co. KG, Hanau, Germany; <sup>3</sup>Budapest University of Technology and Economics, Hungary

12.10 pm Reliability of Advanced Thermal Interface Technologies based on Sintered Die-Attach Materials

Jens Heilmann<sup>1</sup>, Ivan Nikitin<sup>2</sup>, Daniel May<sup>1</sup>, Klaus Pressel<sup>2</sup>, Bernhard Wunderle<sup>1,3</sup>

<sup>1</sup>Chemnitz University of Technology, Germany; <sup>2</sup>Infineon Technologies, Regensburg, Germany; <sup>3</sup>Fraunhofer ENAS, Chemnitz, Germany

12.30 pm Modelling of Graphene and Few-Layer Graphene Heat Spreaders for Hot-Spot Cooling

Yuxiang Ni, Jose Ordonez-Miranda, Yann Chalopin, Sebastian Volz

Ecole Centrale Paris, France

12.50 pm Fabrication and Characterization of a Metal Matrix Polymer Fibre Composite for Thermal Interface Material Applications

Carl Zandén<sup>1</sup>, Xin Luo<sup>1</sup>, Lilei Ye<sup>2</sup>, Johan Liu<sup>1,3</sup>

<sup>1</sup>Chalmers University of Technology, Gothenburg, Sweden; <sup>2</sup>SHT Smart High-Tech AB, Gothenburg, Sweden; <sup>3</sup>Shanghai University, China

## SESSION 12 CLOSING

### Session 12: Fluidics

🕒 2.40 pm – 3.40 pm

SPEKTRUM

➔ Chairs: Yogendra Joshi, Ralph Schacht

**2.40 pm Hybrid Porous Media and Fluid Domain Modeling Strategy to Optimize a Novel Staggered Fin Heat Sink Design**

Ningkang LI<sup>1</sup>, Gerd Schlottig<sup>1</sup>, Marco De-Fazio<sup>3</sup>, Sharma Chander Shekhar<sup>2</sup>,  
Manish Tiwari<sup>2</sup>, Roberto Brioschi<sup>3</sup>, Thomas Brunschwiler<sup>1</sup>  
<sup>1</sup>IBM Research, Zurich, Switzerland; <sup>2</sup>Swiss Federal Institute of Technology in Zurich (ETHz), Switzerland; <sup>3</sup>STMicroelectronics, Agrate, Italy

**3.00 pm Numerical Basis and Validation of CAD-Centric CFD: Honeycomb Heatsink Study**

Travis Mikjaniec, John Parry, Paul Blais  
Mentor Graphics Corporation, Wilsonville, OR, USA

**3.20 pm Co-Design of Multicore Architectures and Microfluidic Cooling for 3D Stacked ICs**

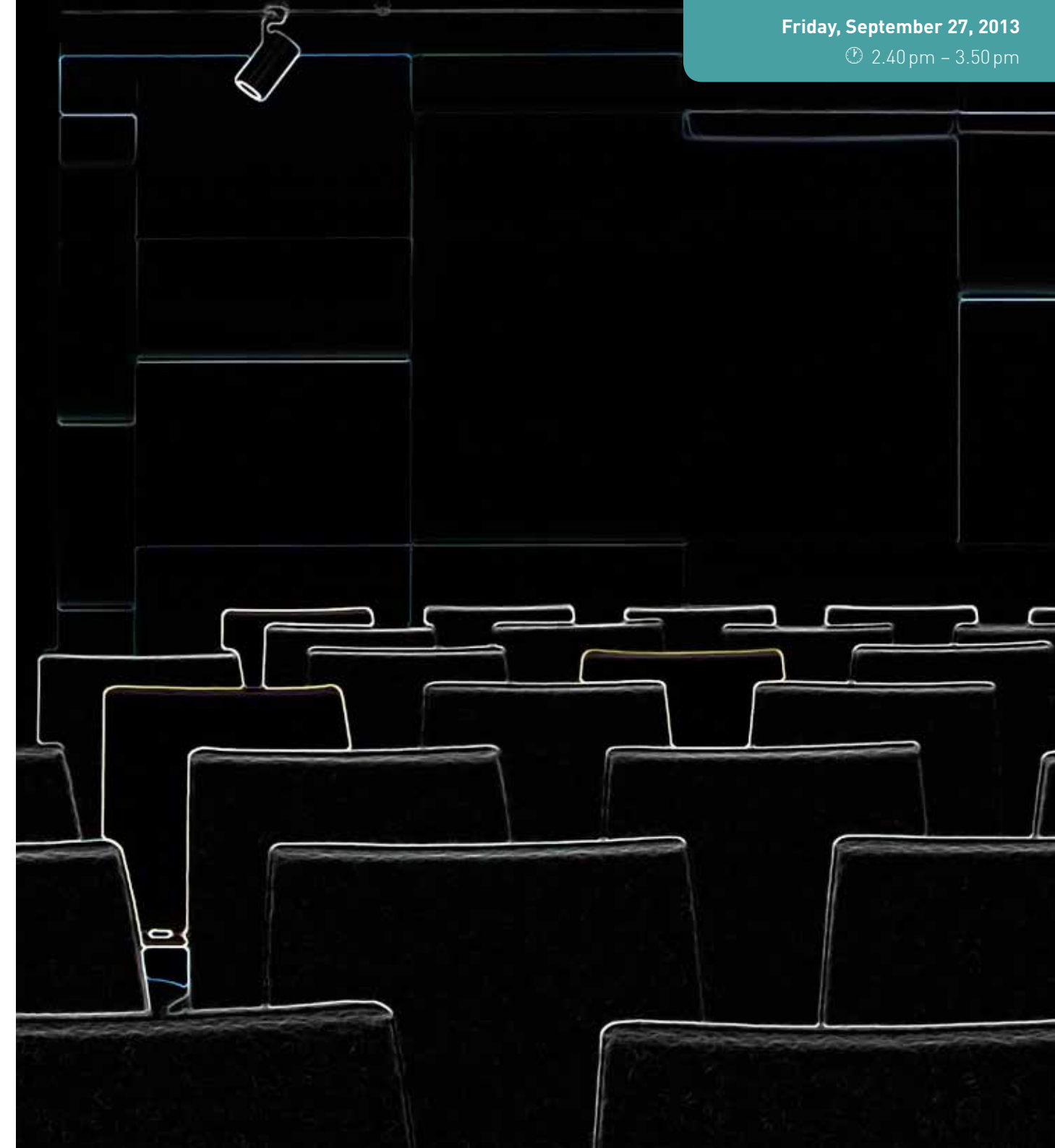
Zhimin Wan, He Xiao, Yogendra Joshi, Sudhakar Yalamanchili  
Georgia Institute of Technology, Atlanta, USA

### Closing Remarks

🕒 3.40 pm – 3.50 pm

Friday, September 27, 2013

🕒 2.40 pm – 3.50 pm



## ABOUT BERLIN

## Berlin... a center of (re)invention

November 9<sup>th</sup>, 1989 marked the beginning of a new chapter in Berlin's history. The eyes of the world watched its residents level the wall that had outraged so many. Shortly afterwards, for the first time in over 28 years, East and West mingled via the Brandenburg Gate, setting the foundation for a new self-understanding. Over the last 20 years, much has changed. Germany's government moved to Berlin in 2001; its institutions, embassies, media, leading corporations, lobby groups and artists, drawn by Berlin's long cultural tradition and its newly emerging hopes and tensions, followed.

A previous no-man's zone that had, along with the wall, epitomized the breach between the two German republics, Potsdamer Platz has been completely rebuilt and rehabilitated to its former position as the city's governmental and commercial center. Many iconic buildings pepper the area, including the »Bundeskanzleramt«, presently home to Chancellor Angela Merkel, and a new central railway station, Europe's largest crossing station. Germany's parliament, the Reichstag, was restored and the inclusion of its famous glass dome, designed by Sir Norman Foster, was considered by some as intended to signal a new era of social and governmental transparency. While the number of new buildings to house political and diplomatic institutions has grown massively, construction is by no means complete. The city remains sprinkled with building sites, and indeed, in this city that has more bridges than Venice, some might argue, always will be.

## Germany's »salad bowl«

Over 3.4 million people live in Berlin; the majority in single-person households. Berlin is Germany's, if not melting pot, then salad bowl of cultures, religions and life styles. Berlin counts as its own residents from more than 150 nations, and is home to the largest Turkish community outside Turkey, which has led to the Kreuzberg district's nickname »Little Istanbul«. Each spring, new and old Berliners from around the world celebrate their cultural backgrounds at »Carnival of Cultures«, which is attended by more than half a million merry-makers. Take a walk around the 12 districts to get the size of this multicultural city, or do like the locals and hop on a bicycle – Berlin is arguably second only to Amsterdam as Europe's cycling capital.

## All things cultural

Berlin is one of the world's most exciting cities. Opera or performance art, antique sculpture or random street art, traditional or contemporary – the city caters to all tastes. With three opera houses, its Museumsinsel (literally, island of museums; a UNESCO World Heritage Site), tourists are kept on the go. Visit the Jewish Museum for an interesting overview of more than 2000 years of Jewish life or the Museum of Technology for a fascinating look at the history of aeroplanes, ships and computers. For fans of obscuria, Kreuzberg's Museum der Dinge (Museum of Objects) offers a lively, eclectic history of everyday items.

Berlin's inner-city districts of Mitte, Prenzlauer Berg, Friedrichshain, Kreuzberg and north Neukölln are home to the city's young and innovative arts scene. Temporary galleries, start-up boutiques, and all variety of musicians abound. These are also among the city's main party zones, with a large variety of clubs, bars, restaurants open around the clock.

Despite the cutting-edge urban experience Berlin offers, nature is never far away, as forests and lakes surround the city. Take a boat down the Spree river, go canoeing in the Spreewald, hiking in Grünewald, cycle part of the new bike path Mauerweg (wall trail), or take in some history at the beautiful Sanssouci palace and park in Potsdam.

## City of science

Berlin has four universities with more than 140,000 students. The city is also home to many other applied and basic research institutes, including the Fraunhofer-Gesellschaft, the Max-Planck-Gesellschaft and two technology parks, making it the perfect location for the Therminic 2013 Workshop!

The Fraunhofer Forum is situated right in the historic center of town, next to the Brandenburg Gate, the boulevard »Unter den Linden«, and the Museumsinsel. Berlin's widely praised public transport system and bike-friendliness ensures longer excursions are easily undertaken.



## NOTES

## NOTES



## CONTACT



(( 19th INTERNATIONAL WORKSHOP  
Thermal Investigations of ICs and Systems ))

### CONFERENCE CHAIR

Peter E. Raad, Southern Methodist University, Dallas, USA

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Jürgen Keller, Amic Angewandte Micro-Messtechnik GmbH

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Pictures kindly provided by the speakers (5), MEV-Verlag (Cover), Fraunhofer (11, 25, 33, 41), Lasertline (43)

Concept, design, editing: mcc Agentur für Kommunikation GmbH